

# February 2012 UniFET-II<sup>TM</sup>

# FDD5N50NZF

# N-Channel MOSFET 500V, 3.7A, 1.75 $\Omega$

#### **Features**

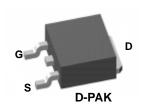
- $R_{DS(on)} = 1.47\Omega$  ( Typ.)@  $V_{GS} = 10V$ ,  $I_D = 1.85A$
- Low Gate Charge (Typ. 9nC)
- Low C<sub>rss</sub> (Typ. 4pF)
- · Fast Switching
- 100% Avalanche Tested
- Improved dv/dt Capability
- · ESD Imoroved Capability
- RoHS Compliant

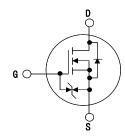


# **Description**

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advance technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switching mode power supplies and active power factor correction.





# MOSFET Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted\*

Symbol		Parameter		FDD5N50NZF	Units
V <sub>DSS</sub>	Drain to Source Voltage	Drain to Source Voltage			
V <sub>GSS</sub>	Gate to Source Voltage			±25	V
1	Drain Current	-Continuous (T <sub>C</sub> = 25°C)		3.7	Α
ID	Diain Current	-Continuous (T <sub>C</sub> = 100°C)		2.2	A
I <sub>DM</sub>	Drain Current	- Pulsed	(Note 1)	14	Α
E <sub>AS</sub>	Single Pulsed Avalanche Er	Single Pulsed Avalanche Energy (N			
I <sub>AR</sub>	Avalanche Current	Avalanche Current		3.3	Α
E <sub>AR</sub>	Repetitive Avalanche Energ	у	(Note 1)	6.25	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	20	V/ns
D	Dower Discipation	$(T_C = 25^{\circ}C)$		62.5	W
$P_{D}$	Power Dissipation	- Derate above 25°C		0.5	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range			-55 to +150	°С
T <sub>L</sub>	Maximum Lead Temperature 1/8" from Case for 5 Second			300	°C

<sup>\*</sup>Drain current limited by maximum junction temperature

### **Thermal Characteristics**

Symbol	Parameter	FDD5N50NZF	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	2	°C/W
$R_{\theta,JA}$	Thermal Resistance, Junction to Ambient 62.5		*C/vv

# **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDD5N50NZF	FDD5N50NZFTM	D-PAK	380mm	16mm	2500

# **Electrical Characteristics** $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Charac	cteristics					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \mu A$ , $V_{GS} = 0 V$ , $T_C = 25 ^{\circ} C$	500	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250\mu\text{A}$ , Referenced to $25^{\circ}\text{C}$	-	0.5	-	V/°C
1	Zoro Coto Voltago Proin Current	$V_{DS} = 500V, V_{GS} = 0V$	-	-	10	
IDSS	Zero Gate Voltage Drain Current	$V_{DS} = 400V, V_{GS} = 0V, T_{C} = 125^{\circ}C$	-	-	100	μΑ
I <sub>GSS</sub>	Gate to Body Leakage Current	$V_{GS} = \pm 25V, V_{DS} = 0V$	-	-	±10	μΑ

### **On Characteristics**

V <sub>GS(th)</sub>	Gate Threshold Voltage $V_{GS} = V_{DS}$ , $I_D = 250\mu A$		3.0	-	5.0	V
R <sub>DS(or</sub>	Static Drain to Source On Resistance $V_{GS} = 10V, I_D = 1.85A$		-	1.47	1.75	Ω
9 <sub>FS</sub>	Forward Transconductance $V_{DS} = 20V, I_D = 1.85A$	(Note 4)	-	4.2	İ	S

# **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V 05V V 0V	-	365	485	pF
C <sub>oss</sub>	Output Capacitance	$V_{DS} = 25V, V_{GS} = 0V$ f = 1MHz		50	65	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 1101112	-	4	8	pF
Q <sub>g(tot)</sub>	Total Gate Charge at 10V		-	9	12	nC
$Q_{gs}$	Gate to Source Gate Charge	$V_{DS} = 400V I_{D} = 3.7A$	-	2	-	nC
$Q_{gd}$	Gate to Drain "Miller" Charge	V <sub>GS</sub> = 10V (Note	4, 5)	4	-	nC

# **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time		-	12	35	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{DD} = 250V, I_D = 3.7A$	-	19	50	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS} = 10V, R_{GEN} = 25\Omega$	-	31	70	ns
t <sub>f</sub>	Turn-Off Fall Time	(Note 4, 5)	-	22	55	ns

# **Drain-Source Diode Characteristics**

IS	Maximum Continuous Drain to Source Diode Forward Current			-		3.7	Α
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Forward Current			=	-	14	Α
$V_{SD}$	Drain to Source Diode Forward Voltage V <sub>GS</sub> = 0V, I <sub>SD</sub> = 3.7A			-	-	1.5	V
t <sub>rr</sub>	Reverse Recovery Time	$V_{GS} = 0V, I_{SD} = 3.7A$		-	87	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$	(Note 4)	-	0.15	-	μС

- Notes:

  1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 23mH, I  $_{AS}$  = 3.7A, V  $_{DD}$  = 50V, R  $_{G}$  = 25 $\Omega$ , Starting T  $_{J}$  = 25 $^{\circ}C$
- 3.  $I_{SD} \le 3.7 \text{A}$ , di/dt  $\le 200 \text{A}/\mu\text{s}$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25^{\circ}C$
- 4. Pulse Test: Pulse width  $\leq 300 \mu s, \, \text{Dual Cycle} \leq 2\%$
- 5. Essentially Independent of Operating Temperature Typical Characteristics

# **Typical Performance Characteristics**

Figure 1. On-Region Characteristics

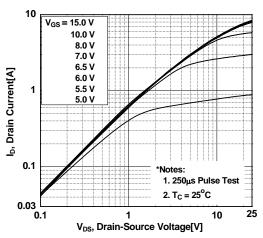


Figure 3. On-Resistance Variation vs.
Drain Current and Gate Voltage

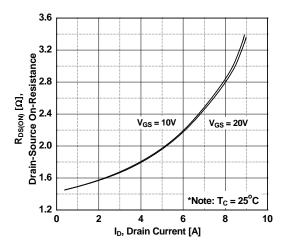


Figure 5. Capacitance Characteristics

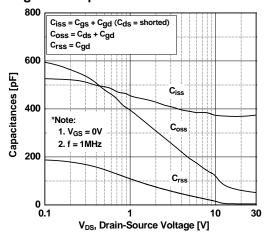


Figure 2. Transfer Characteristics

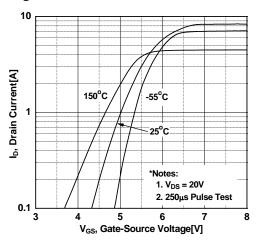


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

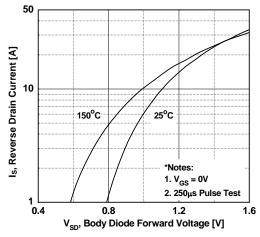
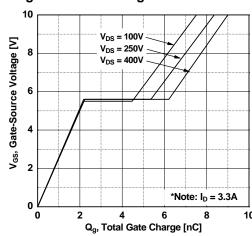


Figure 6. Gate Charge Characteristics



# **Typical Performance Characteristics** (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

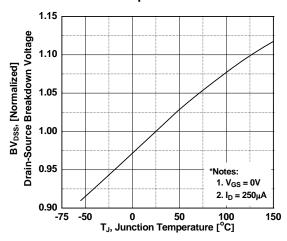


Figure 9. Maximum Safe Operating Area vs. Case Temperature

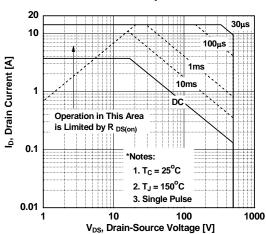


Figure 10. Maximum Drain Current

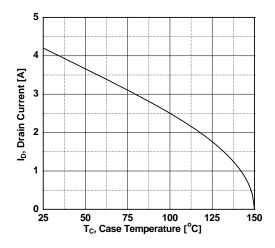
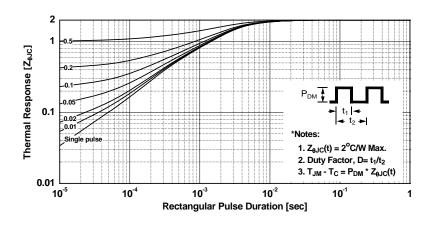
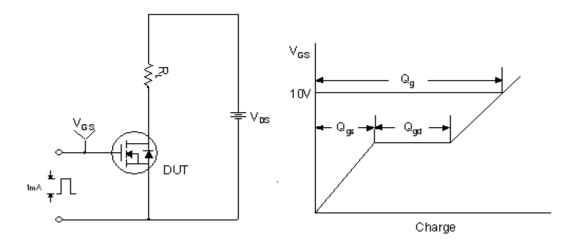


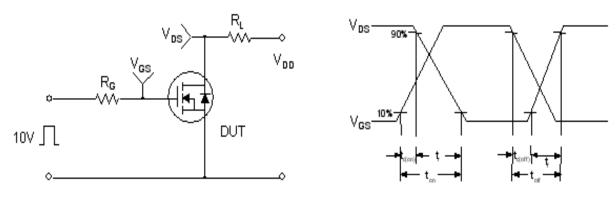
Figure 11. Transient Thermal Response Curve



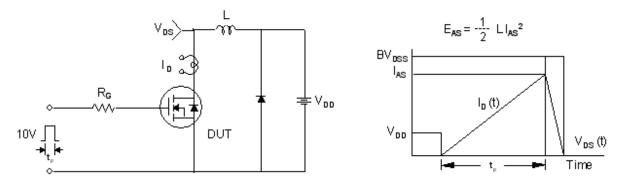
# **Gate Charge Test Circuit & Waveform**



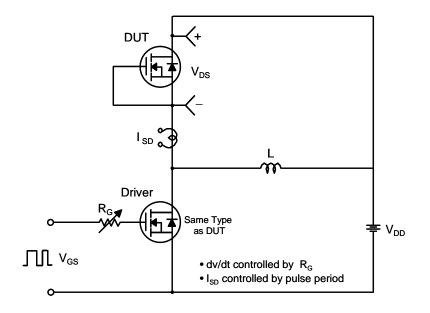
## **Resistive Switching Test Circuit & Waveforms**

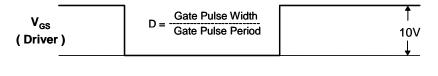


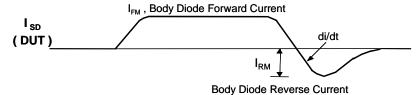
## **Unclamped Inductive Switching Test Circuit & Waveforms**



### Peak Diode Recovery dv/dt Test Circuit & Waveforms







V<sub>DS</sub>
( DUT )

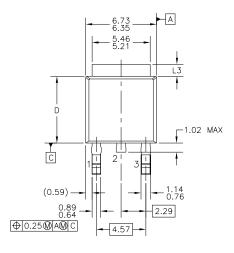
Body Diode Recovery dv/dt

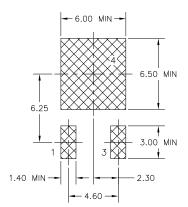
V<sub>SD</sub>

V<sub>DD</sub>

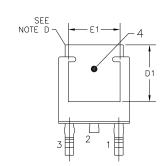
# **Mechanical Dimensions**

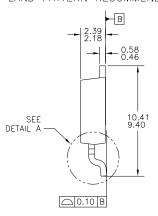
# **D-PAK**

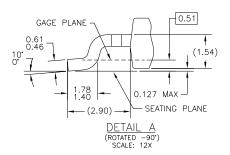




LAND PATTERN RECOMMENDATION







- NOTES: UNLESS OTHERWISE SPECIFIED

  A) ALL DIMENSIONS ARE IN MILLIMETERS.

  B) THIS PACKAGE CONFORMS TO JEDEC, TO-252, ISSUE C, VARIATION AA & AB, DATED NOV. 1999.

  C) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.

  D) HEAT SINK TOP EDGE COULD BE IN CHAMFERED CORNERS OR EDGE PROTRUSION.

  E) DIMENSIONS 1.3.D.E1&D1 TABLE:

0	DINIENSIONS ES,D,E I COT TAL						
		OPTION AA	OPTION AB				
	L3	0.89-1.27	1.52-2.03				
	D	5.97-6.22	5.33-5.59				
	E1	4.32 MIN	3.81 MIN				
	D1	5.21 MIN	4.57 MIN				

F) PRESENCE OF TRIMMED CENTER LEAD IS OPTIONAL.

**Dimensions in Millimeters** 





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No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
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